

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination REPETTO ET AL.	
		Examiner	Art Unit 1795	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,924,974	12-1975	Fischbeck et al.	417/322
*	B	US-3,779,212	12-1973	Wagner, William R.	122/23
*	C	US-4,584,426	04-1986	Nelson, Robert E.	136/253
*	D	US-5,620,531	04-1997	Ikai et al.	136/263
*	E	US-5,403,405	04-1995	Fraas et al.	136/253
*	F	US-4,090,482	05-1978	Yoshida, Masakazu	123/676
*	G	US-6,295,937	10-2001	Nakanishi et al.	110/190
*	H	US-5,512,108	04-1996	Noreen, Darryl L.	136/253
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 58180767 A	10-1983	Japan	YOSHINAGA et al.	136/253
	O	DE 2919743 A	11-1980	Germany	BARNERT K et al.	136/253
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Andriesh, Physics and applications of Non crystalline semiconductors in optoelectronics, 1997, 351.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.